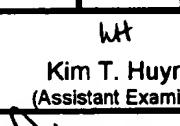
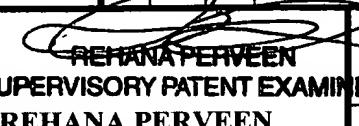
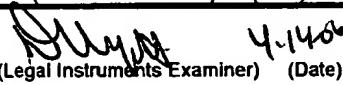


Issue Classification		Application/Control No. 09/750,198	Applicant(s)/Patent under Reexamination VASUDEVAN, ANIL
		Examiner Kim T. Huynh	Art Unit 2112

ISSUE CLASSIFICATION										
ORIGINAL		INTERNATIONAL CLASSIFICATION								
CLASS	SUBCLASS	CLAIMED		NON-CLAIMED						
710	100	G	06	F	13 /00				/	
CROSS REFERENCES						/			/	
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
710	301-304	305				/			/	
709	250					/			/	
370	352					/			/	
						/			/	
						/			/	
 Kim T. Huynh 4/12/06 (Assistant Examiner) (Date)				 REHANA PERVEEN SUPERVISORY PATENT EXAMINER REHANA PERVEEN (Primary Examiner) 4/14/06 (Date)					Total Claims Allowed: 26	
 (Legal Instruments Examiner) (Date)									O.G. Print Claim(s) 1	O.G. Print Fig. 1

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RG 5/10/06

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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